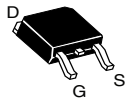
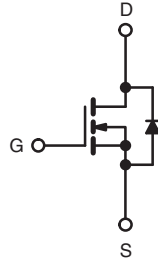
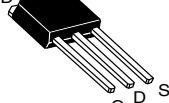


Power MOSFET

| PRODUCT SUMMARY | |
|---------------------------|----------------------------|
| V_{DS} (V) | 200 |
| $R_{DS(on)}$ (Ω) | $V_{GS} = 10\text{ V}$ 1.5 |
| Q_g (Max.) (nC) | 8.2 |
| Q_{gs} (nC) | 1.8 |
| Q_{gd} (nC) | 4.5 |
| Configuration | Single |

 DPAK
(TO-252)

 IPAK
(TO-251)


N-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Surface Mount (IRFR210, SiHFR210)
- Straight Lead (IRFU210, SiHFU210)
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE
Available

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU, SiHFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 W are possible in typical surface mount applications.

| ORDERING INFORMATION | | | | | |
|---------------------------------|---------------|------------------------------|---------------------------|------------------------------|---------------|
| Package | DPAK (TO-252) | DPAK (TO-252) | DPAK (TO-252) | DPAK (TO-252) | IPAK (TO-251) |
| Lead (Pb)-free and Halogen-free | SiHFR210-GE3 | SiHFR210TRL-GE3 ^a | - | SiHFR210TRR-GE3 ^a | SiHFU210-GE3 |
| Lead (Pb)-free | IRFR210PbF | IRFR210TRLPbF ^a | IRFR210TRPbF ^a | - | IRFU210PbF |
| | SiHFR210-E3 | SiHFR210TL-E3 ^a | SiHFR210T-E3 ^a | - | SiHFU210-E3 |

Note

- a. See device orientation.

| ABSOLUTE MAXIMUM RATINGS ($T_C = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | |
|---|----------------------------------|-----------------------------------|---------------|---------------------|
| PARAMETER | SYMBOL | | LIMIT | UNIT |
| Drain-Source Voltage | V_{DS} | | 200 | V |
| Gate-Source Voltage | V_{GS} | | ± 20 | |
| Continuous Drain Current | V_{GS} at 10 V | $T_C = 25\text{ }^\circ\text{C}$ | 2.6 | A |
| | | $T_C = 100\text{ }^\circ\text{C}$ | 1.7 | |
| Pulsed Drain Current ^a | I_{DM} | | 10 | W/ $^\circ\text{C}$ |
| Linear Derating Factor | | | 0.20 | |
| Linear Derating Factor (PCB Mount) ^e | | | 0.020 | |
| Single Pulse Avalanche Energy ^b | E_{AS} | | 95 | mJ |
| Avalanche Current ^a | I_{AR} | | 2.7 | A |
| Repetitive Avalanche Energy ^a | E_{AR} | | 2.5 | mJ |
| Maximum Power Dissipation | $T_C = 25\text{ }^\circ\text{C}$ | | 25 | W |
| | $T_A = 25\text{ }^\circ\text{C}$ | | 2.5 | |
| Peak Diode Recovery dV/dt ^c | dV/dt | | 5.0 | V/ns |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | | - 55 to + 150 | $^\circ\text{C}$ |
| Soldering Recommendations (Peak Temperature) ^d | for 10 s | | 260 | |

Notes

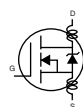

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
 b. $V_{DD} = 50\text{ V}$, starting $T_J = 25\text{ }^\circ\text{C}$, $L = 28\text{ mH}$, $R_g = 25\text{ }\Omega$, $I_{AS} = 2.6\text{ A}$ (see fig. 12).
 c. $I_{SD} \leq 2.6\text{ A}$, $dI/dt \leq 70\text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DS}$, $T_J \leq 150\text{ }^\circ\text{C}$.
 d. 1.6 mm from case.
 e. When mounted on 1" square PCB (FR-4 or G-10 material).



| THERMAL RESISTANCE RATINGS | | | | | |
|--|------------|------|------|------|------|
| PARAMETER | SYMBOL | MIN. | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R_{thJA} | - | - | 110 | °C/W |
| Maximum Junction-to-Ambient (PCB Mount) ^a | R_{thJA} | - | - | 50 | |
| Maximum Junction-to-Case (Drain) | R_{thJC} | - | - | 5.0 | |

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise noted) | | | | | | | |
|---|---------------------|---|--|------|------|-----------|---------------------|
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$ | | 200 | - | - | V |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference to $25\text{ }^\circ\text{C}$, $I_D = 1\text{ mA}$ | | - | 0.30 | - | V/ $^\circ\text{C}$ |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$ | | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I_{GSS} | $V_{GS} = \pm 20\text{ V}$ | | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = 200\text{ V}, V_{GS} = 0\text{ V}$ | | - | - | 25 | μA |
| | | $V_{DS} = 160\text{ V}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$ | | - | - | 250 | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS} = 10\text{ V}$ | $I_D = 1.6\text{ A}^b$ | - | - | 1.5 | Ω |
| Forward Transconductance | g_{fs} | $V_{DS} = 50\text{ V}, I_D = 1.6\text{ A}^b$ | | 0.80 | - | - | S |
| Dynamic | | | | | | | |
| Input Capacitance | C_{iss} | $V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1.0\text{ MHz}$, see fig. 5 | | - | 140 | - | pF |
| Output Capacitance | C_{oss} | | | - | 53 | - | |
| Reverse Transfer Capacitance | C_{rss} | | | - | 15 | - | |
| Total Gate Charge | Q_g | $V_{GS} = 10\text{ V}$ | $I_D = 3.3\text{ A}, V_{DS} = 160\text{ V}$, see fig. 6 and 13 ^b | - | - | 8.2 | nC |
| Gate-Source Charge | Q_{gs} | | | - | - | 1.8 | |
| Gate-Drain Charge | Q_{gd} | | | - | - | 4.5 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 100\text{ V}, I_D = 3.3\text{ A}, R_g = 24\text{ }\Omega, R_D = 30\text{ }\Omega$, see fig. 10 ^b | | - | 8.2 | - | ns |
| Rise Time | t_r | | | - | 17 | - | |
| Turn-Off Delay Time | $t_{d(off)}$ | | | - | 14 | - | |
| Fall Time | t_f | | | - | 8.9 | - | |
| Internal Drain Inductance | L_D | Between lead, 6 mm (0.25") from package and center of die contact  | | - | 4.5 | - | nH |
| Internal Source Inductance | L_S | | | - | 7.5 | - | |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Continuous Source-Drain Diode Current | I_S | MOSFET symbol showing the integral reverse p - n junction diode  | | - | - | 2.6 | A |
| Pulsed Diode Forward Current ^a | I_{SM} | | | - | - | 10 | |
| Body Diode Voltage | V_{SD} | $T_J = 25\text{ }^\circ\text{C}, I_S = 2.6\text{ A}, V_{GS} = 0\text{ V}^b$ | | - | - | 2.0 | V |
| Body Diode Reverse Recovery Time | t_{rr} | $T_J = 25\text{ }^\circ\text{C}, I_F = 3.3\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}^b$ | | - | 150 | 310 | ns |
| Body Diode Reverse Recovery Charge | Q_{rr} | | | - | 0.60 | 1.4 | μC |
| Forward Turn-On Time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300\text{ }\mu\text{s}$; duty cycle $\leq 2\%$.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

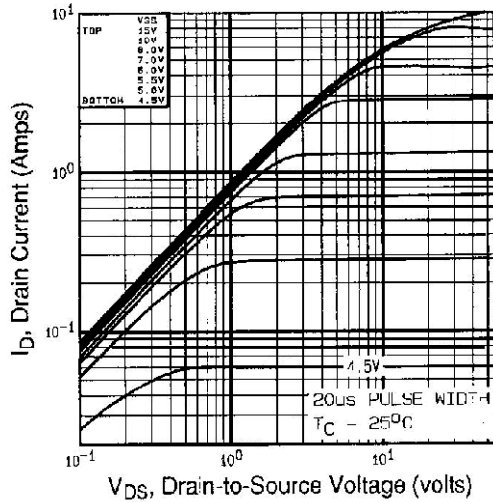


Fig. 1 - Typical Output Characteristics, $T_C = 25\text{ }^\circ\text{C}$

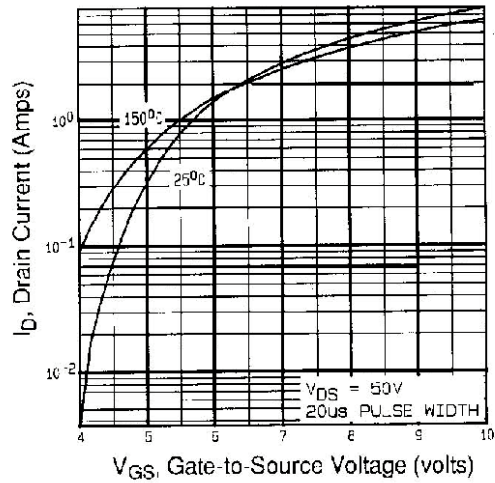


Fig. 3 - Typical Transfer Characteristics

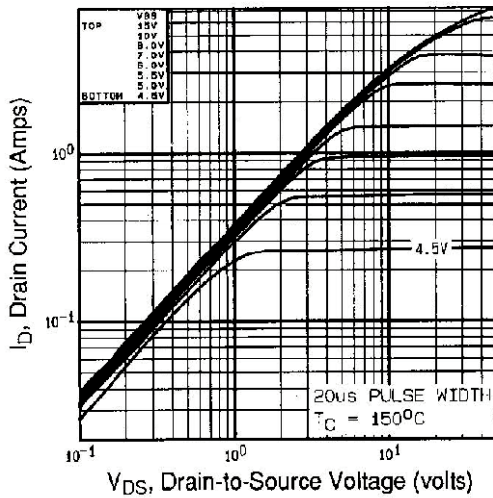


Fig. 2 - Typical Output Characteristics, $T_C = 150\text{ }^\circ\text{C}$

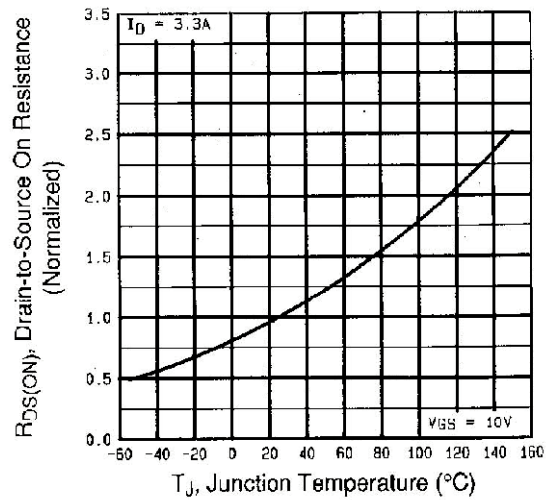


Fig. 4 - Normalized On-Resistance vs. Temperature

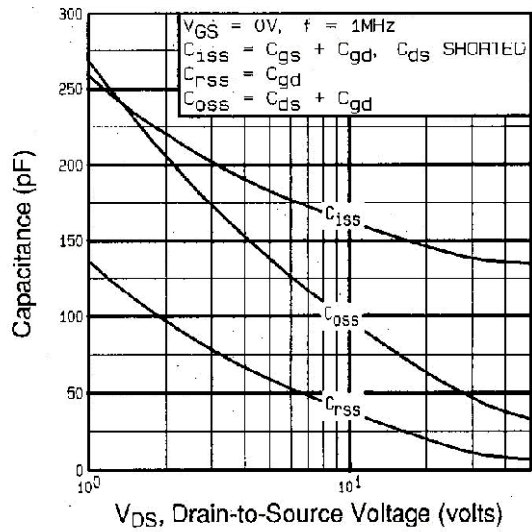


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

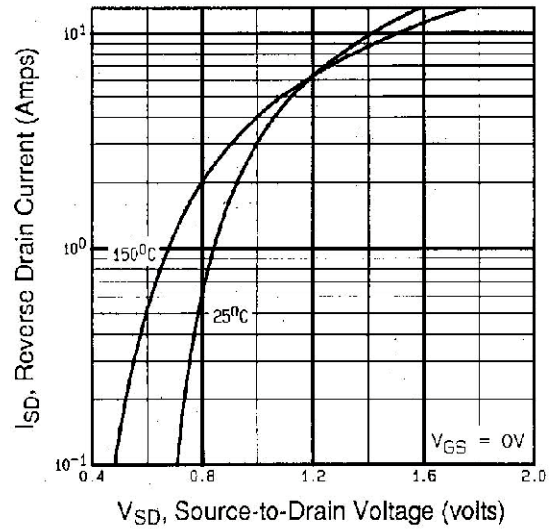


Fig. 7 - Typical Source-Drain Diode Forward Voltage

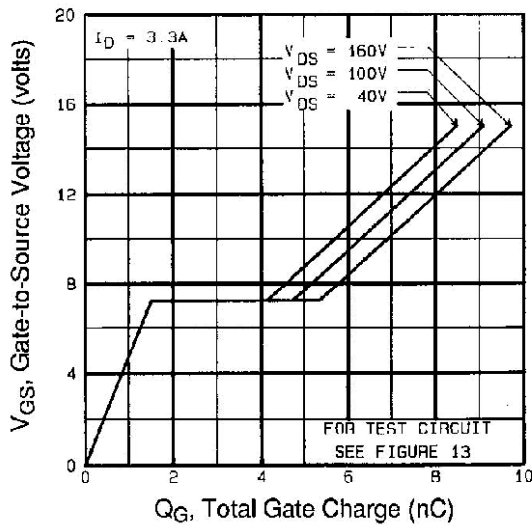


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

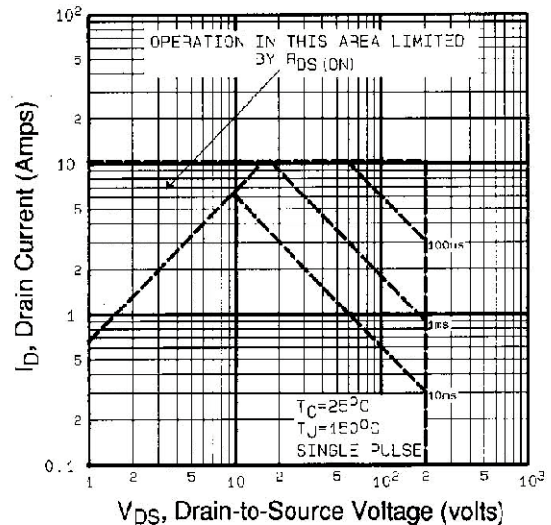


Fig. 8 - Maximum Safe Operating Area

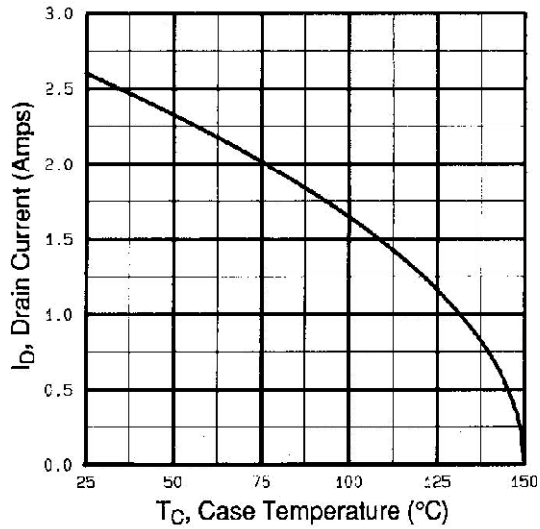


Fig. 9 - Maximum Drain Current vs. Case Temperature

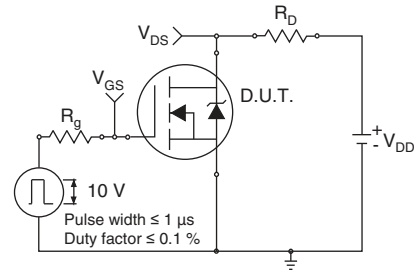


Fig. 10a - Switching Time Test Circuit

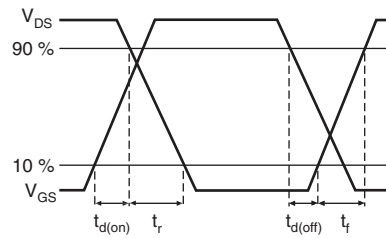


Fig. 10b - Switching Time Waveforms

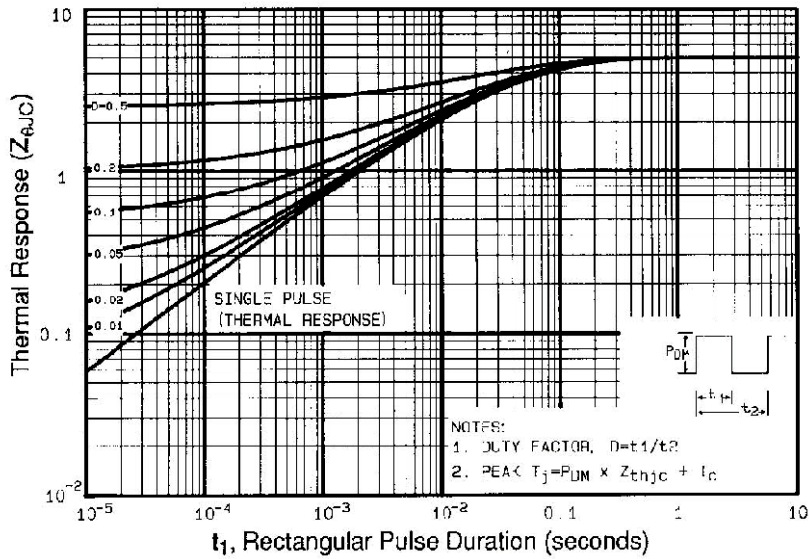


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

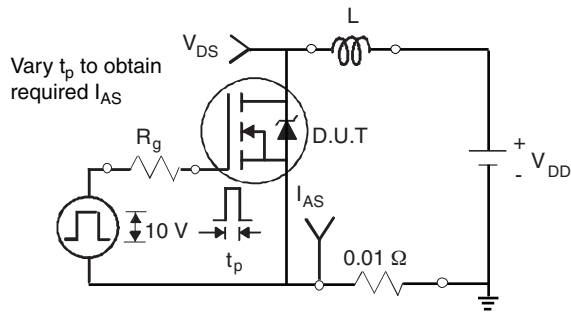


Fig. 12a - Unclamped Inductive Test Circuit



Fig. 12b - Unclamped Inductive Waveforms

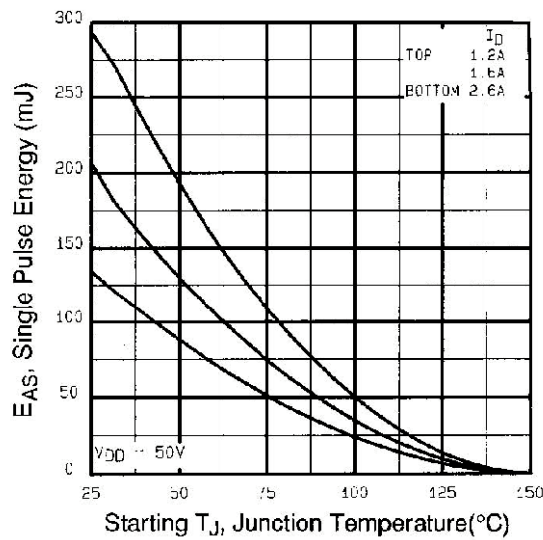


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

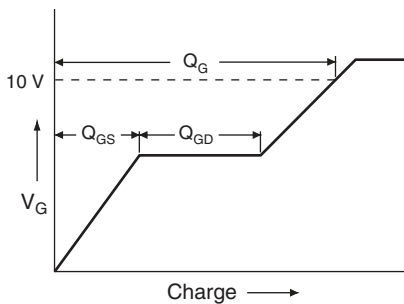


Fig. 13a - Basic Gate Charge Waveform

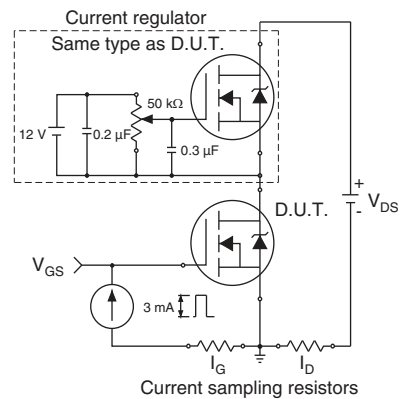
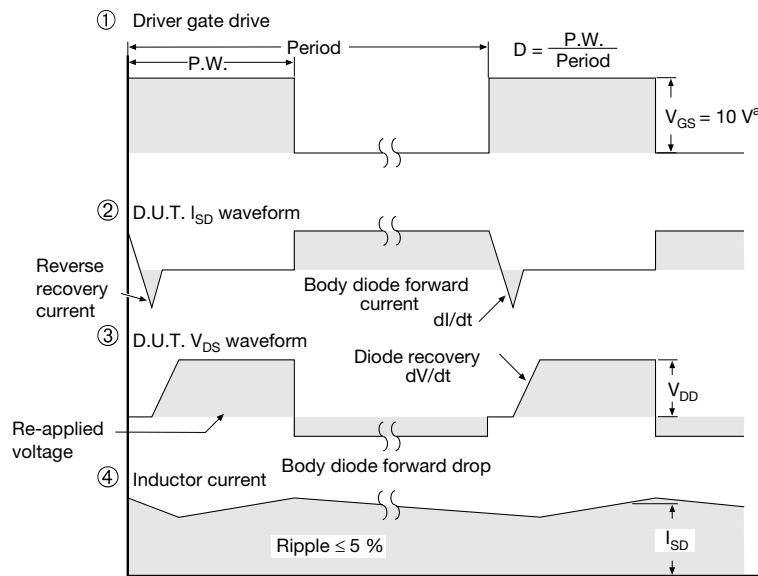
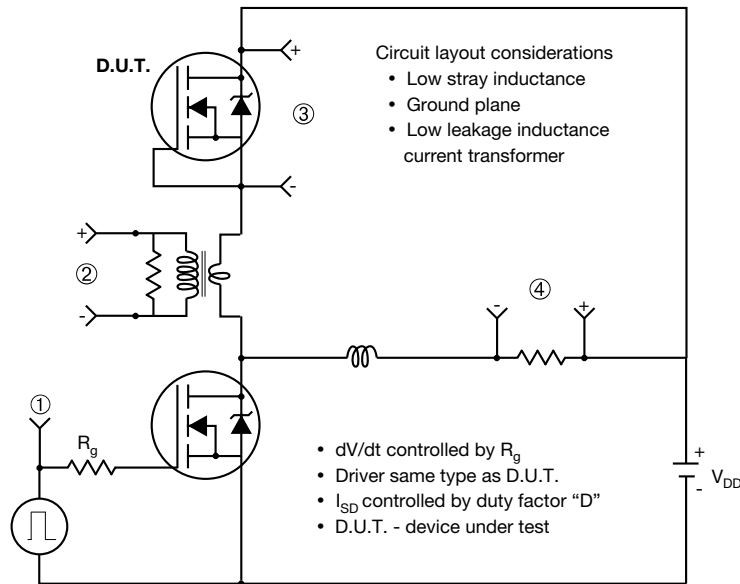


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



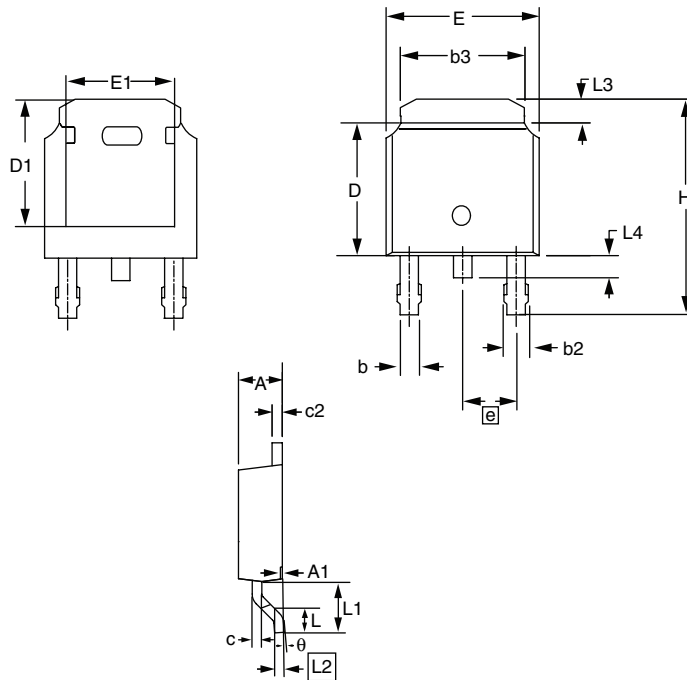
Note

a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91268.

TO-252AA (HIGH VOLTAGE)



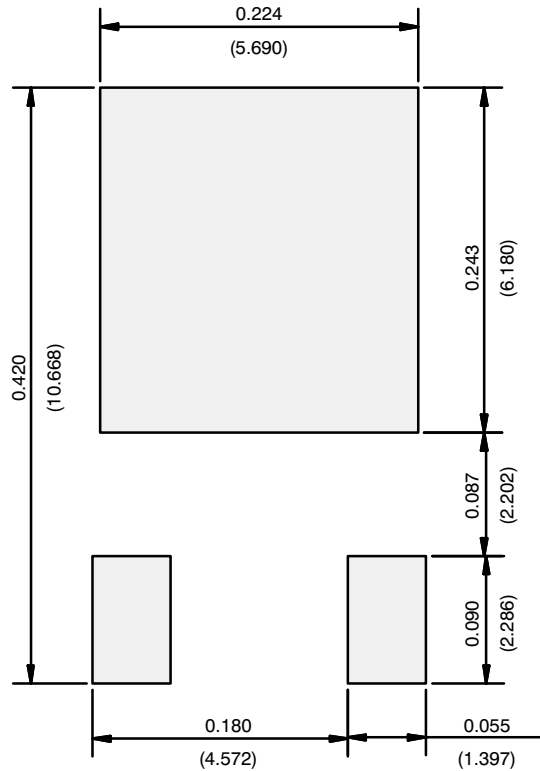
| DIM. | MILLIMETERS | | INCHES | |
|------|-------------|-------|-----------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| E | 6.40 | 6.73 | 0.252 | 0.265 |
| L | 1.40 | 1.77 | 0.055 | 0.070 |
| L1 | 2.743 REF | | 0.108 REF | |
| L2 | 0.508 BSC | | 0.020 BSC | |
| L3 | 0.89 | 1.27 | 0.035 | 0.050 |
| L4 | 0.64 | 1.01 | 0.025 | 0.040 |
| D | 6.00 | 6.22 | 0.236 | 0.245 |
| H | 9.40 | 10.40 | 0.370 | 0.409 |
| b | 0.64 | 0.88 | 0.025 | 0.035 |
| b2 | 0.77 | 1.14 | 0.030 | 0.045 |
| b3 | 5.21 | 5.46 | 0.205 | 0.215 |
| e | 2.286 BSC | | 0.090 BSC | |
| A | 2.20 | 2.38 | 0.087 | 0.094 |
| A1 | 0.00 | 0.13 | 0.000 | 0.005 |
| c | 0.45 | 0.60 | 0.018 | 0.024 |
| c2 | 0.45 | 0.58 | 0.018 | 0.023 |
| D1 | 5.30 | - | 0.209 | - |
| E1 | 4.40 | - | 0.173 | - |
| θ | 0' | 10' | 0' | 10' |

ECN: S-81965-Rev. A, 15-Sep-08
DWG: 5973

Notes

1. Package body sizes exclude mold flash, protrusion or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 0.10 mm per side.
2. Package body sizes determined at the outermost extremes of the plastic body exclusive of mold flash, gate burrs and interlead flash, but including any mismatch between the top and bottom of the plastic body.
3. The package top may be smaller than the package bottom.
4. Dimension "b" does not include dambar protrusion. Allowable dambar protrusion shall be 0.10 mm total in excess of "b" dimension at maximum material condition. The dambar cannot be located on the lower radius of the foot.

RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads
Dimensions in Inches/(mm)

[Return to Index](#)



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Please note that some Vishay documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as Halogen-Free follow Halogen-Free requirements as per JEDEC JS709A standards. Please note that some Vishay documentation may still make reference to the IEC 61249-2-21 definition. We confirm that all the products identified as being compliant to IEC 61249-2-21 conform to JEDEC JS709A standards.



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- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
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- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



Как с нами связаться

Телефон: 8 (812) 309 58 32 (многоканальный)

Факс: 8 (812) 320-02-42

Электронная почта: org@eplast1.ru

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.